

# Search Notes



Application No.

09/987,475

Examiner

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Applicant(s)

KJORLING ET AL.

Art Unit

2654

## SEARCHED

Class	Subclass	Date	Examiner
704	219 501 224 227 262 207	11/6/2004	DAN
704	220 201	11/8/2004	DAN
704	233 234	11/8/2004	DAN
704	206 200.1	11/8/2004	DAN
375	341 240	11/6/2004	DAN
708	311	11/8/2004	DAN
updated above search VBL			
Areas		6/23/05	
704	205	6/23/05	VBL

## INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
704	219, 501 224, 207	6/23/05	VBL
	262, 207 220, 201	6/23/05	VBL
704	233, 234	6/23/05	VBL
704	206, 200-1	6/23/05	VBL
709 375	311 341, 240	6/23/05	VBL

## SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
STIC PLUS scan search	8/3/2004	DAN
EAST full text scan NPL search - Japan Patent Office scan - IEEE text search	11/6/2004	DAN
Confer w/Talis Smits	11/7/2004	DAN